

#### **Datasheet**

Single-channel 5.7 kV (rms) isolated gate driver IC with adjustable DESAT and soft-off

#### **Features**

- 650 V, 1200 V, 1700 V, 2300 V IGBTs, SiC, and Si MOSFETs
- 40 V absolute maximum output supply voltage
- ±3 A, ±6 A, and ±9 A typical sinking and sourcing peak output current
- Separate source and sink outputs for hard switching and with active Miller clamp/clamp driver
- · Adjustment pins for parameter configuration from input side
- Precise V<sub>CEsat</sub> detection (DESAT) with fault output and adjustable filter time and leading edge blanking time with resistor at ADJB pin
- Adjustable IGBT soft turn-off after desaturation detection with resistor at ADJA pin
- Operation at high ambient temperature up to 125 °C with over-temperature shut down at 160 °C (±10 °C)
- Tight IC-to-IC propagation delay matching ( $t_{PDD,max} = 30 \text{ ns}$ )
- Undervoltage lockout protection with hysteresis for input and output side with active shut-down
- High common-mode transient immunity CMTI = 200 kV/μs
- Small space-saving DSO-16 fine-pitch package with large creepage distance (>8 mm)
- · Safety certification
  - UL 1577 recognized (File E311313) with  $V_{ISO,test}$  = 6840 V (rms) for 1 s,  $V_{ISO}$  = 5700 V (rms) for 60 s
  - IEC 60747-17 approval (Certificate no. 40055743) with  $V_{IORM} = 1767 \text{ V}$  (peak, reinforced)
- Evaluation board available EVAL-1ED3491MX12M

# **Potential applications**

- Industrial motor drives compact, standard, premium, servo drives
- Solar inverters
- · UPS systems
- Welding
- Commercial and agricultural vehicles (CAV)
- Commercial air-conditioning (CAC)
- High-voltage isolated DC-DC converters
- Isolated switch mode power supplies (SMPS)



PG-DSO-16

#### **Product validation**

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

**Device information** 



#### **Device information**

Product type	Output current	CLAMP type <sup>1)</sup>	Isolation class	Marking	OPN
1ED3431MC12M	3 A (typ)	CLAMP	reinforced	3431MC12	1ED3431MC12MXUMA1
1ED3461MC12M	6 A (typ)	CLAMPDRV	reinforced	3461MC12	1ED3461MC12MXUMA1
1ED3491MC12M	9 A (typ)	CLAMPDRV	reinforced	3491MC12	1ED3491MC12MXUMA1
1ED3431MU12M	3 A (typ)	CLAMP	UL 1577	3431MU12	1ED3431MU12MXUMA1
1ED3461MU12M	6 A (typ)	CLAMPDRV	UL 1577	3461MU12	1ED3461MU12MXUMA1
1ED3491MU12M	9 A (typ)	CLAMPDRV	UL 1577	3491MU12	1ED3491MU12MXUMA1

<sup>1)</sup> Please refer to Chapter 4.5.4.1 for circuit connection to avoid damage to the gate driver IC

# **Description**

The 1ED34x1Mc12M family (X3 Analog) consists of galvanically isolated single channel gate driver ICs in a small PG-DSO-16 package with a large creepage and clearance of 8 mm. The gate driver ICs provide a typical peak output current of 3 A, 6 A, and 9 A.

Adjustable control and protection functions are included to simplify the design of highly reliable systems. All parameter adjustments are done from the input side, including adjustable DESAT filter time, leading edge blanking time, and soft-off current level with only two resistors..

All logic I/O pins are supply voltage dependent 3.3 V or 5 V CMOS compatible and can be directly connected to a microcontroller.

The data transfer across the galvanic isolation is realized by the integrated coreless transformer technology.

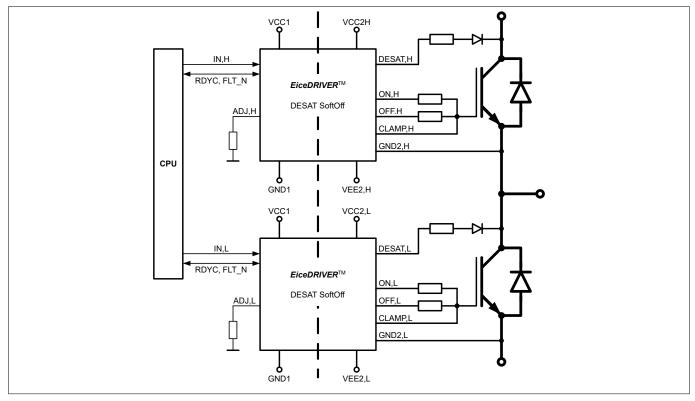
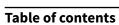


Figure 1 Typical application

## **Datasheet**





# **Table of contents**

	Table of contents	3
1	Block diagram	5
2	Related products	6
3	Pin configuration and functionality	7
3.1	Pin configuration	
3.2	Pin functionality	
4	Functional description	11
4.1	Start-up and fault clearing	11
4.2	Supply	12
4.2.1	Input side undervoltage lockout, VCC1 UVLO	13
4.2.2	Output side under-voltage lockout, VCC2 UVLO	13
4.3	Input side logic	15
4.3.1	IN non-inverting driver input	15
4.3.2	RDYC ready status output, fault-off and fault clear input	15
4.3.2.1	RDYC fault-off input	15
4.3.2.2	RDYC fault clear input	16
4.3.3	FLT_N status output and fault-off input	16
4.3.3.1	FLT_N fault-off input	16
4.4	Desaturation protection	18
4.4.1	DESAT behavior	18
4.4.2	DESAT filter and leading edge blanking time adjustment with ADJB	19
4.5	Gate driver output	21
4.5.1	Turn-on behavior	22
4.5.2	Turn-off and fault turn-off behavior	22
4.5.2.1	Hard switching turn-off	22
4.5.2.2	Soft turn-off	22
4.5.2.2.1	Soft-off current source adjustment with ADJA	23
4.5.3	Active shut-down	23
4.5.4	Active Miller clamp	23
4.5.4.1	CLAMP output types	24
4.5.5	Switch-off timeout until forced switch-off	25
4.6	Short circuit clamping	26
5	Electrical parameters	27
5.1	Absolute maximum ratings	27
5.2	Thermal parameters	28
5.3	Operating parameters	28
5.4	Electrical characteristics	30
5.4.1	Voltage supply	30

# EiceDRIVER™ 1ED34x1Mc12M Enhanced Datasheet



#### **Table of contents**

5.4.2	Logic input and output	31
5.4.3	Analog input	31
5.4.4	Gate driver	33
5.4.5	Active Miller clamp	34
5.4.6	Dynamic characteristics	35
5.4.7	Desaturation protection	36
5.4.8	Soft-off current source	38
5.4.9	Over-temperature protection	39
6	Insulation characteristics (IEC 60747-17, UL 1577) for 1ED34x1MC12M	40
7	Insulation characteristics (UL 1577) for 1ED34x1MU12M	41
8	Package information	42
9	Application notes	43
9.1	Reference layout for thermal data	43
9.2	Printed circuit board guidelines	43
	Revision history	43
	Disclaimer	44

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# 1 Block diagram

# 1 Block diagram

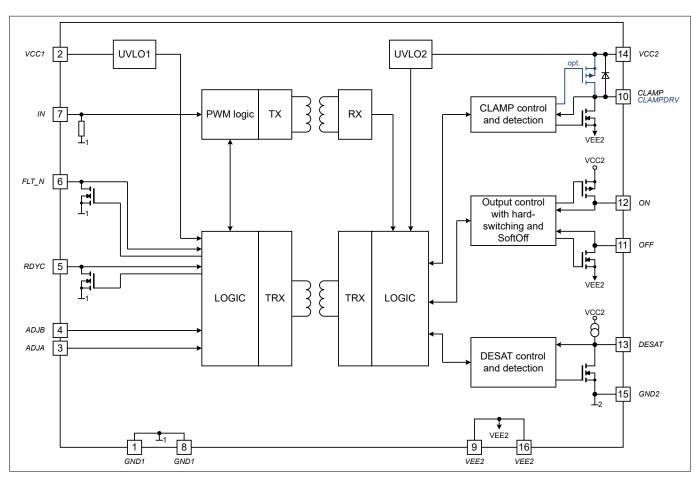


Figure 2 Block diagram

#### **Datasheet**



## 2 Related products

# 2 Related products

Note:

Please consider the gate driver IC power dissipation and insulation requirements for the selected power switch and operating condition.

Product group	Product name	Description				
TRENCHSTOP™	IKWH40N65WR6	650 V, 40 A IGBT with anti-parallel diode in TO-247-3-HCC				
IGBT Discrete	IHW30N160R5	1600 V, 30 A IGBT Discrete with anti-parallel diode in TO-247				
	IKW15N120CS7	1200 V IGBT7 S7, 15 A IGBT with anti-parallel diode in TO247				
	IKQ75N120CS7	1200 V IGBT7 S7, 75 A IGBT with anti-parallel diode in TO247-3				
CoolSiC <sup>™</sup> SiC	IMBF170R1K0M1	$1700\text{V},1000\text{m}\Omega$ SiC MOSFET in TO-263-7 with extended creepage				
MOSFET Discrete	IMZA120R040M1H	1200 V, 40 m $\Omega$ SiC MOSFET in TO247-4 package				
	IMZA120R014M1H	1200 V, 14 m $\Omega$ SiC MOSFET in TO247-4 package				
	IMBG120R030M1H	1200 V, 30 m $\Omega$ SiC MOSFET in TO-263-7 package				
	IMYH200R012M1H	2000 V, 12 m $\Omega$ SiC MOSFET in TO-247-PLUS with high creepage and clearance				
CoolSiC <sup>™</sup> SiC	FS33MR12W1M1H_B11	EasyPACK™ 1B 1200 V, 33 mΩ sixpack module				
MOSFET Module	FF17MR12W1M1H_B11	EasyDUAL™ 1B 1200 V, 17 mΩ half-bridge module				
	FF4MR12W2M1H_B11	EasyDUAL™ 2B 1200 V, 4 mΩ half-bridge module				
	F4-17MR12W1M1H_B11	EasyPACK™ 1B 1200 V, 17 mΩ fourpack module				
TRENCHSTOP™	F4-100R17N3E4	EconoPACK™ 3 1700 V, 100 A fourpack IGBT module				
IGBT Modules	F4-200R17N3E4	EconoPACK™ 3 1700 V, 200 A fourpack IGBT module				
	FP10R12W1T7_B11	EasyPIM™ 1B 1200 V, 10 A three phase input rectifier PIM IGBT module				
	FS100R12W2T7_B11	EasyPACK™ 2B 1200 V, 100 A sixpack IGBT module				
	FP150R12KT4_B11	EconoPIM™ 3 1200V three-phase PIM IGBT module				
	FS200R12KT4R_B11	EconoPACK™ 3 1200 V, 200 A sixpack IGBT module				

#### **Datasheet**



#### 3 Pin configuration and functionality

# 3 Pin configuration and functionality

The pin assignment at the gate driver IC generally differentiates between the input side and the output side.

Pins	Designation
1 to 8	input side, input logic signal side, or low voltage side
9 to 16	output side, driver power side, or high voltage side

For simplicity reasons the driver is described as an IGBT driver. For use with MOSFETs and other power switches simply replace any mentioning of collector and emitter with their corresponding pin names.

## 3.1 Pin configuration

Table 2 Pin configuration table abbreviations

Abbreviation	Description
Pin type	pescription —
PWR	Power supply and gate current output pins
I/O	Digital input and output pin
I	Digital input pin
GND	Ground reference pin
Al	Analog input pin
Buffer type	
OD	Open drain output
CMOS	CMOS compatible input threshold levels
PP	Push/pull output buffer
special	Special output/input function, see individual description
Pull device	·
PD	Pull-down resistor
CS	Current source

Table 3 Pin configuration

Pin no.	Pin name	Pin type	Buffer type	Pull device	Function
1	GND1	GND	_	_	Ground input side
2	VCC1	PWR	_	_	Positive power supply input side
3	ADJA	Al	special	CS	Parameter adjust set A
4	ADJB	AI	special	CS	Parameter adjust set B
5	RDYC	I/O	OD, CMOS	-	Combined ready output, high active and fault clear input and soft-off input, low active
6	FLT_N	I/O	OD, CMOS	_	Fault output, low active and soft- off input, low active
7	IN	I	CMOS	PD, 40 kΩ	Non inverted driver input

(table continues...)

#### **Datasheet**



## **3** Pin configuration and functionality

Table 3 (continued) Pin configuration

Pin no.	Pin name	Pin type	Buffer type	Pull device	Function
8	GND1	GND	_	_	Ground input side
9	VEE2	GND	-	_	Negative power supply output side
10	CLAMP	PWR	OD	_	Active Miller clamping, open drain to VEE2 (1ED3431M only)
10	CLAMPDRV	PWR	PP	-	Active miller clamping, clamp driver for external MOSFET (1ED3461M, 1ED3491M)
11	OFF	PWR, AI	OD	_	Driver sink output
12	ON	PWR, AI	OD	_	Driver source output
13	DESAT	Al	special	CS, 500 μA	Enhanced desaturation protection
14	VCC2	PWR	-	_	Positive power supply output side
15	GND2	Al	-	_	Signal ground output side
16	VEE2	GND	-	_	Negative power supply output side

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		Го		1
	1	ĞND1	VEE2	16
	2	VCC1	GND2	15
	3	ADJA	VCC2	14
	4	ADJB	DESAT	13
	5	RDYC	ON	12
	6	FLT_N	OFF	11
	7	IN	CLAMP	10
	8	GND1	VEE2	9

Figure 3 PG-DSO-16 (top view) with CLAMP

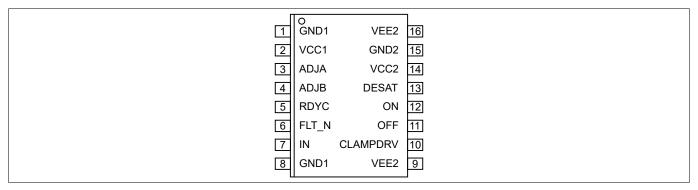


Figure 4 PG-DSO-16 (top view) with CLAMPDRV

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#### **Datasheet**



#### 3 Pin configuration and functionality

#### 3.2 Pin functionality

#### GND1

Reference ground of the input side. Connect direct to input signal ground.

#### VCC1

Positive power supply terminal of the input side, connect to 5 V or 3.3 V for proper operation. Place a decoupling capacitor close to this pin and GND1.

#### ADJA and ADJB parameter adjust input for set A or B

The pins ADJA and ADJB are used to adjust two sets of independent parameters of output functions.

Connect a resistor between 1.33 k $\Omega$  and 28.0 k $\Omega$  to GND1 to adjust each parameter. All valid resistor values belong to the E96-series with 1% tolerance.

Connecting ADJA to GND1 uses a default value for soft switch-off. Connecting it to VCC1 is disabling the gate driver IC.

Connecting ADJB to GND1 is disabling the gate driver IC. Connecting it to VCC1 is setting the function to minimum values.

#### RDYC ready status output, fault-off input and fault-clear input

Open-drain output reports the correct operation of the device, ready output is high active. Fault-clear input and fault-off input clears a gate driver fault or switch the gate driver output to off with fault-off function, input is low active. Connect to a microcontroller with 5 V or 3.3 V I/O with an external pull-up resistor to VCC1. A typical value for this resistor is 2.2 k $\Omega$ . The *RDCY* signal is referenced to *GND1*.

#### FLT\_N fault output and fault-off input

Open-drain output reports the failures related to operating of the inverter system to the microcontroller, fault output is active low. Fault-off input switch the gate driver output to off with fault-off function, input is low active. Connect to a microcontroller with 5 V or 3.3 V I/O with an external pull-up resistor to VCC1. A typical value for this resistor is 2.2 k $\Omega$ . The *FLT\_N* signal is referenced to *GND1*.

#### IN non inverting gate driver input

IN input controls the output of the gate driver IC, the IGBT is turned on if IN is set to high. Connect to a PWM output of the microcontroller with 5 V or 3.3 V IO. An internal pull-down resistor ensures IGBT off-state if not connected. A minimum pulse width of typical 103 ns is defined to make the gate driver IC robust against glitches at IN.

#### VFF2

Negative power supply terminal of the output side. Connect to a voltage of 0 V to -25 V referenced to GND2 for proper operation. Place a decoupling capacitor close to the following pins:

- VCC2 and VEE2
- GND2 and VEE2

If no negative supply voltage is used, all VEE2 pins have to be connected to GND2.

#### CLAMP Miller clamp output, CLAMPDRV Miller clamp pre-driver output

CLAMP: High-current clamp output to hold the gate voltage low during collector-emitter-voltage rise. Connect directly to the gate of the IGBT.

CLAMPDRV: Clamp pre-driver output for the use of an external clamp switch. Connect directly to the gate of a nchannel MOSFET.

#### **Datasheet**



#### 3 Pin configuration and functionality

#### **OFF** driver output

High-current driver sink output to discharge the gate of the external IGBT. The gate driver IC also sinks the Soft-off current at this pin. Connect to the gate of the IGBT via a chosen turn-off gate resistor.

#### **ON** driver output

High-current driver source output to charge the gate of the external IGBT and turn it on and sense input for the CLAMP function. Connect to the gate of the IGBT via a chosen turn-on gate resistor.

#### **DESAT** enhanced desaturation detection input

Desaturation detection input to monitor the IGBT collector-emitter voltage ( $V_{CE}$ ) to detect desaturation caused by short circuit events. Connect to the collector of the driven IGBT via a series connection of a protection resistor and a high-voltage diode. The *DESAT* signal is referenced to *GND2*.

#### VCC2

Positive power supply terminal of the output side. Connect to sufficient supply voltage referenced to *GND2* for proper operation. Place a decoupling capacitor close to the following pins:

- VCC2 and VEE2
- VCC2 and GND2

#### **GND2** reference ground

Reference ground of the output side. Connect to common voltage of a bipolar supply and the emitter of the IGBT. Place a decoupling capacitor close to the following pins:

- VCC2 and GND2
- GND2 and VEE2

#### **Datasheet**

#### 4 Functional description



## 4 Functional description

The 1ED34x1Mc12M family (X3 Analog) consists of galvanically isolated single channel gate driver ICs with adjustable feature parametrization by two simple resistors. All adjustments can be done from the low voltage input side.

To start-up the gate driver IC for normal operation both input and output sides of the gate driver IC need to be powered.

The 1ED34x1Mc12M family (X3 Analog) is designed to support various supply configurations on the input and output side. On the output side unipolar and bipolar supply is possible.

The output stage is realized as rail-to-rail. There the gate driver voltage follows the supply voltage without an additional voltage drop. In addition it provides an easy clamping of the gate voltage during short circuit of an external IGBT.

The *RDYC* status output reports correct operation of the gate driver IC like sufficient voltage supply. The *FLT\_N* status output reports failures in the application like desaturation detection.

To ensure safe operation the gate driver IC is equipped with an input and output side under-voltage lockout circuit. The UVLO levels are optimized for IGBTs.

The desaturation detection circuit protects the external IGBT from destruction at a short circuit. The gate driver IC reacts on a DESAT fault by turning off the IGBT with the adjustable soft-off method.

The soft turn-off function is used to switch-off the external IGBT in overcurrent conditions in a soft-controlled manner to protect the IGBT against collector emitter over-voltages.

An active Miller clamp function protects the IGBT from parasitic turn-on in fast switching applications.

## 4.1 Start-up and fault clearing

For normal operation both input and output sides of the gate driver IC need to be powered. A low level at the FLT\_N pin always indicates a fault condition. In this case the IC starts internal mechanisms for fault clearing.

#### Input side start-up

- 1. Voltage at VCC1 reaches the input UVLO threshold: input side of gate driver IC starts operating
- **2.** *FLT\_N* follows input supply voltage
- 3. Records resistor programmable function from ADJA and ADJB
- **4.** Waits until output side is powered
- 5. Initiates internal start-up: Transfers configured values to output side
- **6.** Performs internal self-test

The start-up delay takes approx. 200  $\mu$ s and is part of the complete start-up time  $t_{START1}$ .

#### **Output side start-up**

- 1. Voltage at VCC2 reaches the output UVLO threshold: output side of gate driver IC starts operating
- 2. Activates OFF gate driver output: connected gate stays discharged
- **3.** Waits until input side is powered
- 4. Initiates internal start-up: Receives configured values from input side
- **5.** Performs internal self-test

The start-up delay takes approx. 200  $\mu$ s and is part of the complete start-up time  $t_{\text{START2}}$ .

The gate driver IC releases *RDYC* to high to signal a successful start-up and its readiness to operate. The gate driver IC will follow the status of the *IN* signal.

#### Clearing a fault with RDYC to low cycle

- **1.** Set *IN* to low
- **2.** Set *RDYC* to low for a duration longer than the fault clear time  $t_{CLRMIN}$

#### **Datasheet**

# infineon

#### 4 Functional description

- **3.** Release *RDYC* to high
  - **a.** If the source of the fault is no longer present, FLT\_N is released to high
  - **b.** If another fault source is active, *FLT\_N* stays low and the cycle needs to be repeated
- **4.** Continue PWM operation

#### 4.2 Supply

The 1ED34x1Mc12M family (X3 Analog) is designed to support various supply configurations. The input side can be used with a 3.3 V or 5 V supply.

The output side requires either an unipolar supply (VEE2 = GND2) or a bipolar supply.

- Individual supply voltages between VCC2 and GND2 or GND2 and VEE2 shall not exceed 25 V.
- The total supply voltage between VCC2 and VEE2 shall not exceed 35 V.

To ensure safe operation of the gate driver IC, it is equipped with an input and output side undervoltage lockout circuit.

#### **Unipolar supply**

In unipolar supply configuration the gate driver IC is typically supplied with a positive voltage of 15 V at VCC2. GND2 and VEE2 are connected together and this common potential is connected to the IGBT emitter.

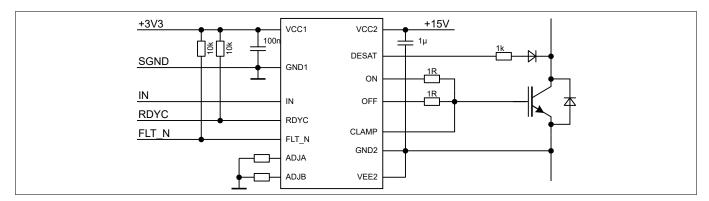


Figure 5 Application example with unipolar supply (1ED3431M)

#### **Bipolar supply**

For bipolar supply the gate driver IC is typically supplied with a positive voltage of 15 V at VCC2 and a negative voltage of -8 V or -15 V at VEE2 relative to GND2.

Between VCC2 and VEE2 the maximum potential difference is 35 V.

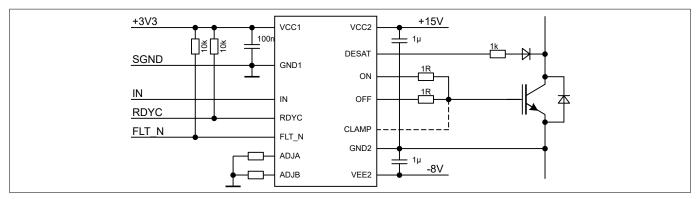


Figure 6 Application example with bipolar supply (1ED3431M)

Negative supply prevents a parasitic turn-on due to the additional voltage margin to the gate turn-on threshold.

#### **Datasheet**

#### 4 Functional description



#### VEE2 over GND2 supply connection check

The gate driver IC has a built-in connection check for VEE2. A loss of VEE2 connection will be detected and signaled via RDYC.

## 4.2.1 Input side undervoltage lockout, VCC1 UVLO

To ensure correct operation of the input side and safe operation of the application the gate driver IC is equipped with an input supply undervoltage lockout for *VCC1*.

UVLO behavior during start-up:

- **1.** The voltage at the supply terminal *VCC1* reaches the  $V_{UVLO1H}$  threshold
- 2. The gate driver IC reads the *ADJA* and *ADJB* resistor values and transfers the configuration to the output side
- **3.** The IC releases the *RDYC* output to **high** and is ready to operate.

The start-up delay takes approx. 200  $\mu$ s and is part of the complete start-up time  $t_{\text{START1}}$ .

UVLO behavior during shut-down:

• If the supply voltage  $V_{VCC1}$  of the input side drops below  $V_{UVLO1L}$  the RDYC signal is switched to **low** and the output will be switched off.

The fault signal *FLT\_N* follows the input supply voltage.

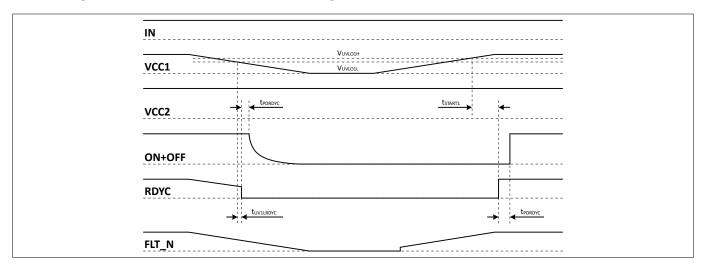


Figure 7 UVLO *VCC1* behavior

# 4.2.2 Output side under-voltage lockout, VCC2 UVLO

To ensure correct operation of the output side and safe operation of the IGBT in the application, the gate driver IC is equipped with an output supply undervoltage lockout for *VCC2* versus *GND2*.

UVLO behavior during start-up:

• If the voltage at the supply terminal VCC2 reaches the  $V_{UVLO2H}$  threshold the RDYC output is released to **high** and the gate driver IC is ready to operate.

The start-up delay takes approx. 200  $\mu$ s and is part of the complete start-up time  $t_{\text{START2}}$ .

UVLO behavior during shut-down:

• If the supply voltage  $V_{VCC2}$  of the output side drops below  $V_{UVLO2L}$  the RDYC signal is switched to **low** and the output will be switched off.

#### **Datasheet**



#### **4 Functional description**

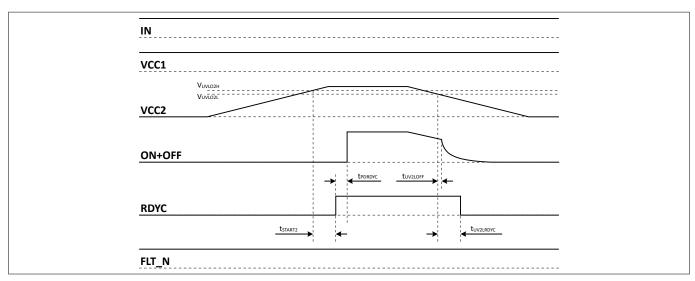


Figure 8 UVLO VCC2 behavior

Any  $V_{\rm UVLO2L}$  event will lead to a fault-off and a *RDYC* low level. Depending of the level of the voltage drop, the gate driver IC either stays in a not ready state and waits for the supply voltage to recover, or it will fully reset the gate driver IC. Both variants differ in the necessary delay of *RDYC* release after the supply voltage has recovered. After a reset, the gate driver IC needs to fully restart until it becomes ready again.

#### **Datasheet**

#### **4 Functional description**



## 4.3 Input side logic

The input threshold levels are always CMOS compliant. The threshold levels are 30% of *VCC1* for low level and 70% of *VCC1* for high level.

The 1ED34x1Mc12M family (X3 Analog) has three input pins (*IN*, *ADJA*, *ADJB*) and two I/O pins (*RDYC*, *FLT\_N*) at the input side.

## 4.3.1 IN non-inverting driver input

The input pin has a positive logic. To turn on the associated IGBT apply a logic high signal at the *IN* pin. A minimum pulse width of typical 103 ns is defined to make the IC robust against glitches at *IN*.

### 4.3.2 RDYC ready status output, fault-off and fault clear input

The RDYC pin is a logic input and open drain output and has three different functions:

- RDYC as ready status output of all ready sources
- · RDYC as fault-off input
- RDYC as fault clear input

In a typical application the *RDYC* pins of all gate driver ICs in the inverter are connected together and form a single wire *RDYC* signal.

An external pull-up resistor is required to ensure RDYC status output during operation.

#### **Ready sources**

- the input side is properly supplied, VCC1 supply above UVLO1 threshold
- the output side is properly supplied with a positive voltage, VCC2 supply above UVLO2 threshold
- no VEE2 over GND2 failure
- Internal signal transmission is operating nominal
- the ON pin monitoring of the gate driver is below VEE2 + 2 V, IGBT has to be off at start-up

## 4.3.2.1 RDYC fault-off input

Pulling *RDYC* to low disables the operation of the gate driver IC. The gate driver IC ignores *IN* signals as long as the *RDYC* pin stays low and the IC uses its fault-off function to switch-off the IGBT.

The defined minimum pulse width makes the IC robust against glitches at *RDYC*. The gate driver ignores pulses with a shorter duration.

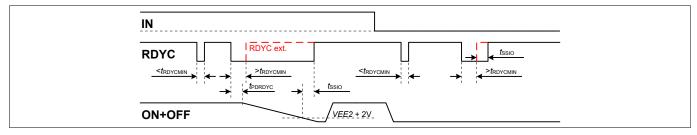


Figure 9 RDYC short pulse behavior of external manipulation of the RDYC pin

After an external *RDYC* low signal the IC is actively pulling *RDYC* to low until the voltage at *ON* pin falls below the *VEE2*+2 V threshold.

The RDYC fault-off input is active low.

#### **Datasheet**

#### 4 Functional description



#### 4.3.2.2 RDYC fault clear input

Setting *RDYC* to low for longer than the fault clear time  $t_{CLRMIN}$  will reset the stored fault signal at pin *FLT\_N* with the rising edge of *RDYC*. Additionally the following conditions have to be met as well:

- PWM IN pin level needs to be low,
- voltage at ON pin has dropped below the VEE2+2 V threshold, and
- triggering fault condition is no longer present.

The typical fault clear time  $t_{CLRMIN}$  is 1.0 µs.

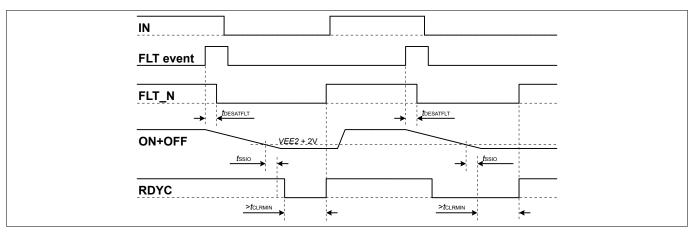


Figure 10 RDYC fault clear timing

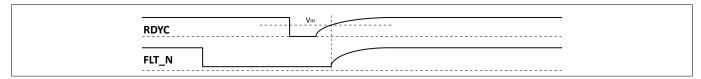


Figure 11 RDYC fault clear rising edge to FLT\_N

### 4.3.3 FLT\_N status output and fault-off input

The FLT\_N pin is a logic input and open drain output and has two different functions:

- FLT\_N as fault-status output for fault sources
- FLT\_N as fault-off input

In a typical application the FLT\_N pins of all gate driver ICs in the inverter are connected together and form a single wire FLT\_N signal.

An external pull-up-resistor is required to ensure FLT\_N status output during operation.

#### **Fault sources**

Datasheet

The following fault sources can trigger a FLT\_N pin to low and initiate a fault turn-off:

- · desaturation detection of IGBT
- gate driver over temperature protection

## 4.3.3.1 FLT\_N fault-off input

Pulling FLT\_N to low disables the operation of the gate driver IC. The gate driver IC ignores IN signals as long as the FLT\_N pin stays low and the IC uses its fault-off function to switch-off the IGBT.

The defined minimum pulse width makes the gate driver IC robust against glitches at FLT N.

After a low at the FLT N pin either internally or externally applied, the fault event is latched until cleared.

16

v1.20

#### **Datasheet**



## 4 Functional description

The FLT\_N fault-off input is active low.

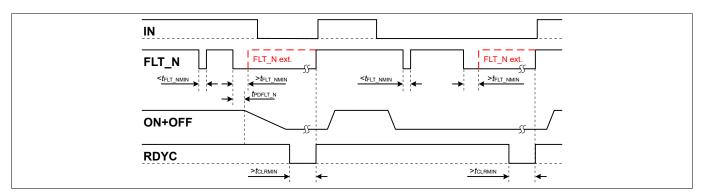


Figure 12 FLT\_N short pulse behavior of external manipulation of the FLT\_N pin cleared by RDYC

#### **Datasheet**

#### 4 Functional description



#### 4.4 Desaturation protection

The desaturation detection circuit protects the external IGBT from destruction at a short circuit. The desaturation protection follows the given sequence:

- 1. Voltage at DESAT pin reaches DESAT threshold level, for a period of time exceeding the filter time
- 2. Gate driver IC output switches the external IGBT off, using the soft-off method
- **3.** Gate driver IC switches FLT N pin to low to indicate the fault to a connected microcontroller
- **4.** Short circuit situation is resolved
  - after the voltage at the ON pin has dropped below the VEE2+2 V threshold,
  - no other fault condition is present,
  - · the input has been turned off and
  - the fault has been cleared using the RDYC low cycle method

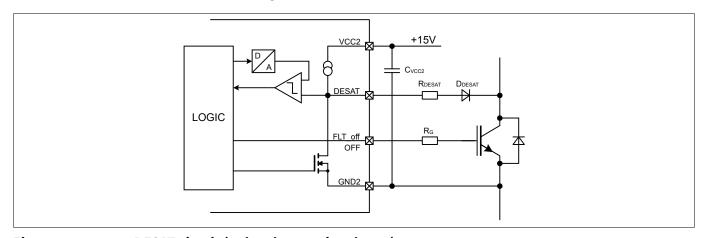


Figure 13 DESAT circuit (only relevant pins shown)

The 1ED34x1Mc12M family (X3 Analog) has a fixed DESAT threshold level of typical 9.18 V. If lower threshold levels are required, the DESAT resistor can be increased. Larger DESAT resistor values lead to lower DESAT threshold voltages. The threshold voltage reduction is equal to the DESAT current multiplied by the DESAT resistance.

The high-precision internal current source results in a minimum impact on the DESAT detection variation.

#### 4.4.1 DESAT behavior

The DESAT function offers a leading edge blanking time and filters to optimize the DESAT detection for application usage.

The leading edge blanking inhibits threshold detection during an IGBT turn on phase. The typical IGBT turn on behavior starts with charging of the gate, commutation of the application load current and finally  $V_{CE}$  voltage decrease to  $V_{CEsat}$  voltage levels. To prevent the gate driver IC from detecting a false DESAT event, leading edge blanking pauses the DESAT circuit until the time  $t_{DESATleb}$  has elapsed.

Following the leading edge blanking time, the gate driver IC forces the DESAT current into the external DESAT circuit. The current typically flows through a protection resistor, a fast high voltage diode and the collectoremitter path of the IGBT. The resulting voltage at the *DESAT* pin is the sum of the voltage drop across this path.

During a short circuit condition, the  $V_{\text{CE}}$  voltage increases, resulting in a reverse polarity condition of the DESAT diode. The remaining DESAT current also increases the voltage level at the *DESAT* pin and triggers the DESAT threshold. If the pin voltage level stays above the threshold for the duration of the DESAT filter time  $t_{\text{DESATfilter}}$ , the gate driver IC registers the DESAT event and acts accordingly.

The internal processing time after DESAT threshold crossing, filtering and beginning of fault-off is defined as  $t_{\text{DESATOUT}}$ . The duration of the gate discharge during fault-off is defined as  $t_{\text{FLTOFFtot}}$  and is depending on the soft-off function and the gate load.

#### **Datasheet**

# infineon

#### 4 Functional description

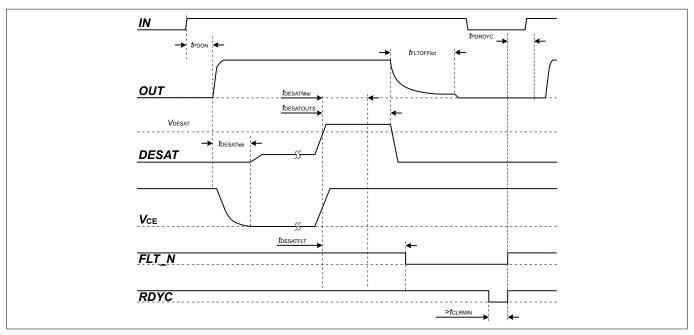


Figure 14 DESAT timing with leading edge blanking, filter and reaction times

## 4.4.2 DESAT filter and leading edge blanking time adjustment with ADJB

The ADJB pin configures the DESAT leading edge blanking time and DESAT filter time:

- A resistor from *ADJB* to *GND1* sets the DESAT leading edge blanking time and the DESAT filter time used during DESAT detection
- Use resistors from the E96 resistor-series with 1% tolerance values to achieve accurate parameter configuration
- The gate driver IC reads the resistor value once during start-up
- Connecting ADJB to GND1 inhibits the gate driver operation and stops the start-up sequence
- Connecting ADJB to VCC1 disables the filtering resulting in minimum response times

Table 4 DESAT filter timing ADJB adjustment

DESAT filter time set up	stopped	0	1	2	3	4	5	6	7
Resistance at ADJB to GND1	<pre>1.05 k<math>\Omega</math> or tied to GND1</pre>	1.33 kΩ	1.58 kΩ	1.91 kΩ	2.26 kΩ	2.74 kΩ	3.32 kΩ	4.02 kΩ	4.87 kΩ
typ. t <sub>DESATleb</sub>	inhibit	650 ns							
typ. t <sub>DESATfilter</sub>	gate driver operatio n	1575 ns	1775 ns	1975 ns	2375 ns	2775 ns	3175 ns	3575 ns	3975 ns

## **Datasheet**



## 4 Functional description

DESAT filter time set up	8	9	10	11	12	13	14	15	default
Resistance at ADJB to GND1	5.90 kΩ	7.15 kΩ	8.66 kΩ	10.7 kΩ	13.7 kΩ	17.4 kΩ	23.2 kΩ	28.0 kΩ	$>45.3 \text{ k}\Omega$ or tied to <i>VCC1</i>
typ. t <sub>DESATleb</sub>	1150 ns	400 ns							
typ. t <sub>DESATfilter</sub>	3975 ns	3575 ns	3175 ns	2775 ns	2375 ns	1975 ns	1775 ns	1575 ns	225 ns

#### **Datasheet**

# infineon

#### **4 Functional description**

## 4.5 Gate driver output

The gate driver output side uses MOSFETs to provide a rail-to-rail output. Therefore, the gate drive voltage follows the supply voltage closely.

Due to the low internal voltage drop, the switching behavior of the IGBT is predominantly governed by the external gate resistor. The gate driver IC offers separate sink and source outputs to adapt the gate resistor for turn-on and turn-off separately without additional bypass components.

The cell value x in the following table is placeholder for high or low and indicates that this pin does not influence the resulting gate driver output state. The arrow  $(\rightarrow)$  in cells indicate the transition initiated by the pin of the logic input and gate driver supply pins resulting in a transition to the gate driver output state as listed.

Table 5 Driver output state including transition behavior

Logic inp	ut and gate driver		Gate driver output			
IN	RDYC	FLT_N	VCC1	VCC2	ON	OFF
Static gat	e driver output stat	e: on and off	'			,
high	high	high	high	high	high	tri-state
low	high	high	high	high	tri-state	low
Transition	n to not ready and s	tatic not ready	state			
x	high → low	high	high	high	→ tri-state	→ fault off
x	low	high	high	high	tri-state	low
Transitior	n to fault and static	fault state				
x	high	high → low	high	high	→ tri-state	→ fault off
x	high	low	high	high	tri-state	low
Transitior	n with VCC1 power l	oss and unsupp	olied input side			
x	х	х	high → low	high	→ tri-state	→ fault off
х	х	х	low	high	tri-state	low
Transition	n with VCC2 power l	oss and unsupp	olied output sid	e	<u>'</u>	•
х	х	х	х	high → low	→ tri-state	→ fault off
X	х	х	Х	low	tri-state	active shut down

#### **Datasheet**

#### 4 Functional description



#### 4.5.1 Turn-on behavior

The 1ED34x1Mc12M family (X3 Analog) is optimized for hard switching turn-on. A turn-on command switches the ON pin internally to VCC2.

#### 4.5.2 Turn-off and fault turn-off behavior

The gate driver IC supports different turn-off sequences to adapt to different applications and IGBT currents during normal switching operation and in the case of a fault.

Table 6 Turn-off sequences

Turn-off reason	Turn-off sequence	Turn-off sequence					
	Hard switching	Soft turn-off					
normal off	X						
fault turn-off		Х	adjustable via ADJA				

The gate driver fault turn-off behavior can be configured with the ADJA pin

Once started, the fault turn-off sequence cannot be interrupted by an IN = low turn-off signal.

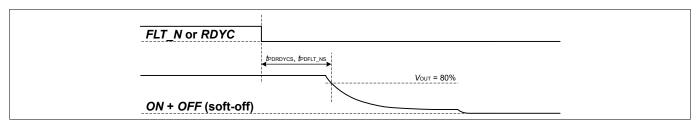


Figure 15 Fault turn-off sequence initiated by FLT\_N or RDYC

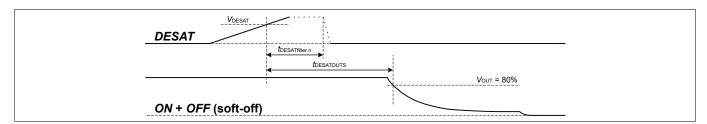


Figure 16 Fault turn-off sequence initiated by DESAT event

### 4.5.2.1 Hard switching turn-off

The gate driver IC supports hard switching turn-off during normal switching operation. Switching the IGBT gate off by turning on the discharge MOSFET in the output stage, the *OFF* pin is switched to *VEE2* pin.

#### 4.5.2.2 Soft turn-off

The soft turn-off function protects the IGBT against collector-emitter overvoltage during turn off in an overcurrent condition. It turns-off the IGBT with a reduced gate current to reduce the di/dt induced overvoltage..

The IGBT gate is connected via *OFF* to an internal current sink circuit. The discharge current is typically lower than the hard switch-off current used for normal operation. Since soft turn-off is a single event after a failure, the gate driver IC can handle the additional power dissipation internally.

Soft turn-off can be configured with the ADJA pin. The function is only active during fault turn-off.

The adjustable range depends on the current strength of the gate driver IC:

#### **Datasheet**



#### 4 Functional description

1ED3431M: 15 mA - 233 mA
1ED3461M: 29 mA - 466 mA
1ED3491M: 44 mA - 699 mA

### 4.5.2.2.1 Soft-off current source adjustment with ADJA

The ADJA pin configures the Soft-off function and current level:

- A resistor from ADJA pin to GND1 sets the Soft-off current level for the fault-off function
- Use resistors from the E96 resistor-series with 1% tolerance values to achieve accurate parameter configuration
- The gate driver IC reads the resistor value once during start-up
- Connecting ADJA to GND1 results in a Soft-off function for fault-off with a predefined value
- Connecting ADJA to VCC1 inhibits the gate driver operation and stops the start-up sequence

Table 7 Soft-off adjustment with ADJA

Soft-off set up	default		0		1		2		3		4		5		6		7
Resistance from ADJA to GND1	< 1.05 kΩ or tied to GND1		1.33 ks	Ω	1.58 ks	Ω	1.91 k	Ω	2.26 k	Ω	2.74 k	Ω	3.32 k	Ω	4.02 k	ĸΩ	4.87 kΩ
typ. I <sub>CSOFF</sub> 1ED3431M	146 mA		15 mA		29 mA		44 mA	1	58 mA	ı	73 m/	4	87 m <i>A</i>	4	102 m	nΑ	116 mA
typ. I <sub>CSOFF</sub> 1ED3461M	291 mA		29 mA		58 mA		87 mA		116 m	A	146 m	ıΑ	175 m	ıΑ	204 m	ıΑ	233 mA
typ. I <sub>CSOFF</sub> 1ED3491M	437 mA		44 mA		87 mA		131 m	Α	175 m	A	218 m	ıΑ	262 m	ıΑ	306 m	ıΑ	349 mA
Soft-off set up	8	9		10	)	11		12		13	3	14		15	;	ste	pped
Resistance from <i>ADJA</i> to <i>GND1</i>	5.90 kΩ	7.	15 kΩ	8.	66 kΩ	10	.7 kΩ	13	.7 kΩ	17	'.4 kΩ	23	.2 kΩ	28	.0 kΩ		5.3 kΩ or d to <i>VCC1</i>
typ. I <sub>CSOFF</sub> 1ED3431M	131 mA	14	16 mA	16	50 mA	17	'5 mA	18	9 mA	20	)4 mA	21	.8 mA	23	3 mA	inhibit gate driver operation	
typ. I <sub>CSOFF</sub> 1ED3461M	262 mA	29	91 mA	32	20 mA	34	9 mA	37	9 mA	40	)8 mA	43	7 mA	46	6 mA		
typ. I <sub>CSOFF</sub> 1ED3491M	393 mA	43	37 mA	48	80 mA	52	4 mA	56	8 mA	61	.2 mA	65	5 mA	69	9 mA		

#### 4.5.3 Active shut-down

The active shut-down feature ensures a safe IGBT off-state, if the output chip is not supplied. It protects the IGBT against a floating gate. The IGBT gate is always clamped via *OFF* to *VEE2*.

#### 4.5.4 Active Miller clamp

Datasheet

The 1ED34x1Mc12M family (X3 Analog) is equipped with an active Miller clamp function to protect the IGBT from parasitic turn-on in fast switching applications.

23

After a turn-off command the gate driver IC follows the implemented sequence:

1. Discharge of the IGBT gate while monitoring the voltage level at the ON pin

v1.20

#### **Datasheet**

# infineon

#### 4 Functional description

- 2. Detection of a voltage at the ON pin less than a level of VEE2 + 2.0 V
- 3. Filtering of the detection to avoid false CLAMP activation and not to influence regular turn-off behavior
- **4.** Activating clamp function to keep IGBT gate at *VEE2* level

#### 4.5.4.1 CLAMP output types

The CLAMP output stage offers two operating modes:

- direct gate clamping with an open drain output for medium clamping current, 1ED3431M variants
- pre-driver output, to clamp IGBT gate with external transistor for high clamping current, 1ED3461M and 1ED3491M variants

#### **Direct gate clamping**

Direct gate clamping with an open drain output is tailored for direct clamping of IGBT gate to *VEE2*. The output current capability is typically 2 A. Useful IGBT current rating for direct gate clamping is a collector current of typically smaller than 100 A. Connect the *CLAMP* pin directly to the gate with low inductive tracks.

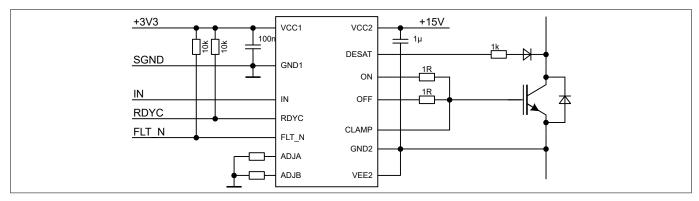


Figure 17 Application example with unipolar supply (1ED3431M)

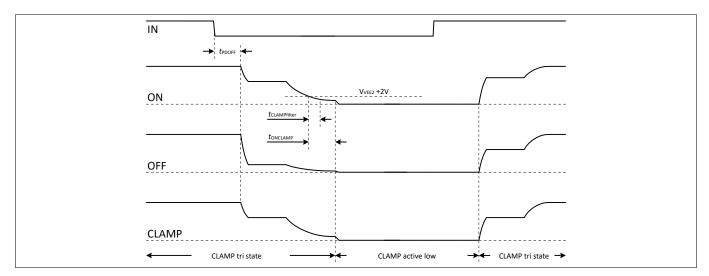


Figure 18 Direct clamp output behavior

#### **Pre-driver output**

Track inductance and clamp output resistance reduces the clamping capability for large IGBTs. In this case, select the pre-driver output product variant with an external MOSFET.

The external small signal n-channel MOSFET transistor in combination with the pre-driver output enables clamping of high gate currents. Connect the MOSFET between the *CLAMPDRV* output, *VEE2* pin, and IGBT gate. Due to the pre-driver configuration the clamp current is only limited by the external clamp MOSFET transistor.

#### **Datasheet**



#### 4 Functional description

Depending on the external MOSFET a Miller current clamping up to 20 A can be reached. The clamping MOSFET has to be placed close to the IGBT gate to minimize track resistance and inductance.

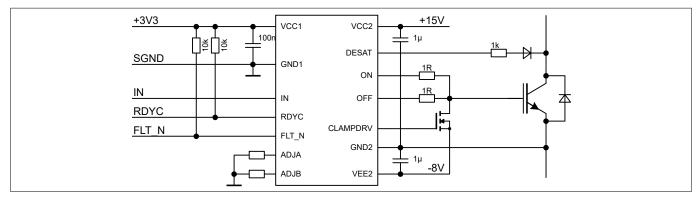


Figure 19 Application example with bipolar supply and CLAMP pre-driver output (1ED3461M, 1ED3491M)

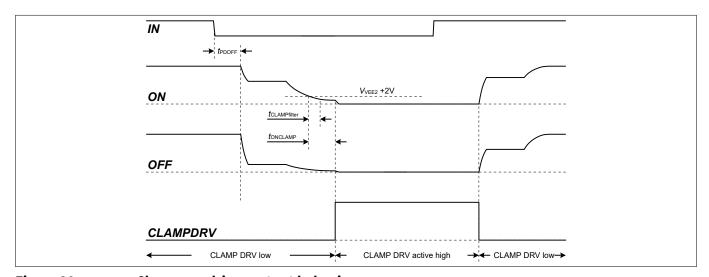


Figure 20 Clamp pre-driver output behavior

## 4.5.5 Switch-off timeout until forced switch-off

The gate driver IC is equipped with a switch-off timeout monitoring feature. In case the pin monitoring comparator has not registered an off-state within the timeout time this feature activates a forced switch-off.

The monitoring feature secures the IGBT switch-off in case of a connection failure between the *OFF* output and the IGBT gate or a faulty gate resistor. In a forced switch-off all available output switch-off paths (*OFF* and *CLAMP/CLAMPDRV*) will be used to hard switch-off the IGBT after such an event.

#### **Datasheet**

# infineon

#### 4 Functional description

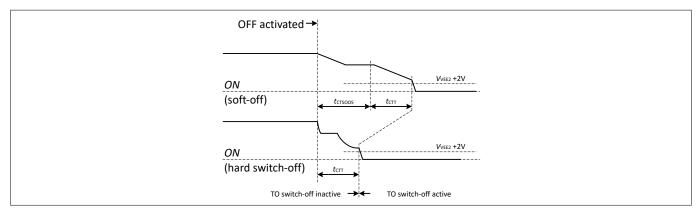


Figure 21 Switch-off timeout behavior

The timing diagram shows the switch-off timeout behavior from the moment of *OFF* output activation until the timeout has elapsed and the *CLAMP* output is activated.

### 4.6 Short circuit clamping

The integrated short circuit clamping diode limits the IGBT gate over voltage during a short circuit. The over voltage is typically triggered by the capacitive feedback of the Miller capacitance.

The internal diodes from *ON* and *CLAMP* to *VCC2* limit the gate driver voltage to a value slightly higher than the supply voltage. These diode paths are rated for a maximum current of 0.75 A and the duration of 6 µs. Add an external Schottky diode if higher currents are expected or a tighter clamping is desired. Also use an external diode if the active Miller clamping circuit uses the pre-driver output configuration.

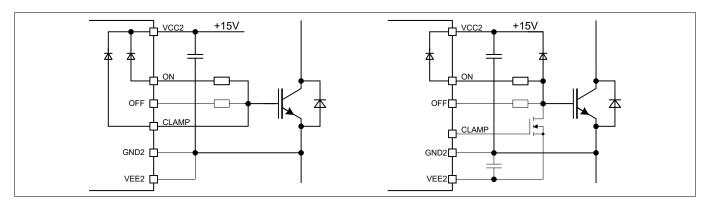


Figure 22 Short circuit clamping circuitry

#### **Datasheet**

#### **5 Electrical parameters**



# 5 Electrical parameters

# 5.1 Absolute maximum ratings

Note:

Absolute maximum ratings are defined as ratings, which when being exceeded may lead to destruction of the integrated circuit. Unless otherwise noted all voltages are given with respect to their respective GND (GND1 for pins 1 to 8, GND2 for pins 9 to 16).

Table 8 Absolute maximum ratings

Parameter	Symbol	Values		Unit	Note /
		Min.	Max.		Test Condition
Input to output offset voltage	V <sub>OFFSET</sub>	-	2300	V	$V_{\text{VEE2,max}}$ - $V_{\text{VEE2,min}}$ with $V_{\text{VEE2,max}} \ge V_{\text{GND1}}$ $\ge V_{\text{VEE2,min}}^{1/2}$
Supply voltage input side	$V_{VCC1}$	-0.3	6.5	V	_
Logic input voltage (IN)	$V_{\text{LogicIN}}$	-0.3	6.5	V	_
Logic input voltage (RDYC, FLT_N)	$V_{\text{LogicRF}}$	-0.3	6.5	V	_
Logic input voltage (ADJA, ADJB)	$V_{LogicAD}$	-0.3	6.5	V	-
Open drain logic output current (RDYC, FLT_N)	I <sub>LogicOC</sub>	_	10	mA	-
Positive supply voltage output side	V <sub>VCC2</sub>	-0.3	40	V	-
Negative supply voltage output side	$V_{VEE2}$	-40	0.3	٧	-
Maximum supply voltage difference output side ( $V_{VCC2}$ - $V_{VEE2}$ )	V <sub>max2</sub>	_	40	V	-
DESAT input voltage	V <sub>DESAT</sub>	-0.3	V <sub>VCC2</sub> +0.3	V	_
CLAMP input voltage	V <sub>CLAMP</sub>	V <sub>VEE2</sub> -0.3	V <sub>VCC2</sub> +0.3	V	3)
Maximum <i>CLAMP</i> output current	I <sub>CLAMP</sub>	_	2.4	А	t < 5 μs
Gate driver output voltage (ON, OFF)	V <sub>OUT</sub>	V <sub>VEE2</sub> -0.3	V <sub>max2</sub> +0.3	V	-
Maximum <i>CLAMP</i> to <i>VCC2</i> diode IGBT short circuit clamping time	t <sub>CLP</sub>	_	6	μs	$I_{\text{CLAMP/OUT}} = 0.75 \text{ A}$
Junction temperature	TJ	-40	150	°C	-
Storage temperature	$T_{Stg}$	-55	150	°C	-
Power dissipation, input side	$P_{D,IN}$	_	100	mW	@T <sub>A</sub> = 25 °C
Power dissipation, output side	$P_{D,OUT}$	_	700	mW	$@T_{A} = 25^{\circ}C^{4)}$
ESD capability: Human body model	V <sub>ESDHBM</sub>	_	2	kV	5)
ESD capability: Charged device model	V <sub>ESDCDM</sub>	_	500	V	6)

<sup>1)</sup> for functional operation only

Datasheet

27

v1.20

<sup>2)</sup> See also

<sup>3)</sup> May be exceeded during short circuit clamping.

<sup>4)</sup> Derating the power above 65°C with 8 mW/°C

<sup>5)</sup> According to ANSI/ESDA/JEDEC-JS-001-2017 (discharging a 100 pF capacitor through a 1.5 k $\Omega$  series resistor).

#### **Datasheet**

# **(infineon**

#### **5 Electrical parameters**

6) According to ANSI/ESDA/JEDEC-JS-002-2014 (TC = test condition in volt)

### 5.2 Thermal parameters

Thermal performance may change significantly with layout and heat dissipation of components in close proximity.

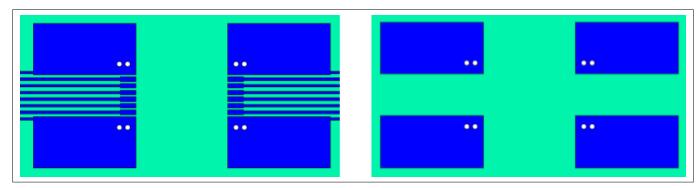


Figure 23 Reference layout for thermal data (Two layer PCB; copper thickness 35 μm; left: top layer; right: bottom layer)

The PCB layout represents the reference layout used for the thermal characterization. Pins 1 and 8 (*GND1*) and pins 9 and 16 (*VEE2*) require ground plane connections for achieving maximum power dissipation. The 1ED34x1Mc12M family (X3 Analog) is conceived to dissipate most of the heat generated through these pins.

Table 9 Thermal parameters

Parameter	Symbol	Value	Unit	Note / Test Condition
Thermal resistance junction to ambient	R <sub>THJA,OUT</sub>	122	K/W	$@T_A = 65^{\circ}\text{C}, P_{D, \text{OUT}} = 400 \text{ mW},$ $P_{D, \text{IN}} = 50 \text{ mW}, 4 \text{ layer test PCB},$
Characterization parameter junction to package top input side	$\Psi_{Jtop}$	8	K/W	PG-DSO-16

### 5.3 Operating parameters

Note:

Within the operating range the IC operates as described in the functional description. Unless otherwise noted all voltages are given with respect to their respective GND (GND1 for pins 1 to 8, GND2 for pins 9 to 16).

Table 10 Operating parameters

Parameter <sup>1)</sup>	Symbol	Values		Unit	Note /	
		Min.	Max.		Test Condition	
Supply voltage input side	V <sub>VCC1</sub>	3.0	5.5	V	_	
Logic input voltages (IN, RDYC, FLT_N)	$V_{LogicIN}$	-0.3	5.5	V	_	
Positive supply voltage output side	V <sub>VCC2</sub>	13	25	V	_	
Negative supply voltage output side	V <sub>VEE2</sub>	-25	0	V	-	
Supply voltage difference output side $(V_{VCC2} - V_{VEE2})$	V <sub>max2</sub>	13	35	V	-	

(table continues...)

v1.20

#### **Datasheet**



#### **5 Electrical parameters**

Table 10 (continued) Operating parameters

Parameter <sup>1)</sup>	Symbol	Values		Unit	Note / Test Condition	
		Min.	Max.			
Ambient temperature	$T_{A}$	-40	125	°C	2)	
Switching frequency	$f_{\sf SW}$	0	250	kHz	max P <sub>D</sub> applies	
Common mode transient immunity	CMTI	0	200	V/ns	V <sub>OFFSET,test</sub> = 1500 V	

Parameter is not subject to production test - verified by design/characterization

<sup>1)</sup> 2)  $T_{\rm J}$  has to be below over temperature protection temperature  $T_{\rm OTPOFF}$ 

#### **Datasheet**

# infineon

#### **5 Electrical parameters**

#### 5.4 Electrical characteristics

Note:

The electrical characteristics include the spread of values in supply voltages, load, and junction temperatures within the operating parameters unless specified otherwise. Typical values represent the median values at  $T_A = 25$ °C. Unless otherwise noted all voltages are given with respect to their respective GND (GND1 for pins 1 to 8, GND2 for pins 9 to 16).

# 5.4.1 Voltage supply

Table 11 Voltage supply

Parameter	Symbol		Values		Unit	Note or Test
		Min.	Тур.	Max.		Condition
VCC1 UVLO threshold	V <sub>UVLO1H</sub>	_	2.95	3.05	V	-
	V <sub>UVLO1L</sub>	2.6	2.8	_	V	-
VCC1 UVLO hysteresis (V <sub>UVLO1H</sub> - V <sub>UVLO1L</sub> )	V <sub>HYS1</sub>	0.1	0.14	_	V	-
VCC1 quiescent current	$I_{\mathrm{Q}1}$	-	2.4	4.0	mA	$V_{VCC1} = 3.3 \text{ V, } IN =$ High, $RDYC = \text{High,}$ $FLT_N = \text{High}$
VCC1 operating current	I <sub>O1</sub>	-	2.4	4.0	mA	V <sub>VCC1</sub> = 3.3 V, IN = 16 kHz, 50%, RDYC = High, FLT_N = High
VCC2 UVLO threshold	V <sub>UVLO2H,0</sub>	_	12.0	12.6	V	
	$V_{\rm UVLO2L,0}$	10.4	11.0	_	V	
VCC2 UVLO hysteresis (V <sub>UVLO2H,0</sub> - V <sub>UVLO2L,0</sub> )	V <sub>HYS2,0</sub>	0.75	1.0	_	V	
VEE2 not connected detection threshold	V <sub>VEE2,NC</sub>	-	0.5	-	V	V <sub>VEE2</sub> - V <sub>GND2</sub>
VCC2 quiescent current	$I_{\mathrm{Q2}}$	-	3.9	5	mA	$V_{VCC2} = 15 \text{ V}, V_{VEE2}$ = -8 V, <i>OUT</i> = High, <i>DESAT</i> = Low
VCC2 operating current	I <sub>O2</sub>	-	3.9	5	mA	$V_{VCC2} = 15 \text{ V}, V_{VEE2} = $ -8 V, $OUT = 16 \text{ kHz},$ $50\%, DESAT = \text{Low},$ $C_{\text{LOAD}} = 100 \text{ pF}$

#### **Datasheet**

#### **5 Electrical parameters**



# 5.4.2 Logic input and output

Table 12 Logic input and output

Parameter	Symbol		Values	Unit	Note or Test	
		Min.	Тур.	Max.		Condition
Logic low input voltage (IN, RDYC, FLT_N)	V <sub>LogicINL</sub>	-	-	30	%	of V <sub>VCC1</sub>
Logic high input voltage (IN, RDYC, FLT_N)	V <sub>LogicINH</sub>	70	-	-	%	of V <sub>VCC1</sub>
Logic low output voltage (RDYC, FLT_N)	V <sub>RDYC5</sub> , V <sub>FLT_N5</sub>	-	-	300	mV	I <sub>SINK</sub> = 5 mA
Logic input pull down resistor (IN)	R <sub>INPD</sub>	33	40	47	kΩ	-
Logic input pull down resistor (RDYC, FLT_N)	R <sub>RDYCPD</sub> , R <sub>FLT_NPD</sub>	0.8	1.0	1.2	МΩ	-

# 5.4.3 Analog input

Resistor values outside of the 1% tolerance range results in the gate driver IC selecting either the lower or higher step for the corresponding function.

Table 13 Analog input

Parameter <sup>1)</sup>	Symbol		Values		Unit	Note or Test				
		Min.	Тур.	Max.		Condition				
Analog input resistor (ADJA,	R <sub>ADJx0</sub>	_	1.33	_	kΩ	all resistor values ar				
ADJB)	R <sub>ADJx1</sub>	_	1.58	-		from the E96-series with 1% tolerance				
	R <sub>ADJx2</sub>	_	1.91	_		with 170 toterance				
	R <sub>ADJx3</sub>	_	2.26	-						
	R <sub>ADJx4</sub>	_	2.74	_						
	R <sub>ADJx5</sub>	_	3.32	_						
	R <sub>ADJx6</sub>	_	4.02	_						
	R <sub>ADJx7</sub>	_	4.87	_						
	R <sub>ADJx8</sub>	_	5.90	_						
	R <sub>ADJx9</sub>	_	7.15	_						
	R <sub>ADJx10</sub>	_	8.66	_						
	R <sub>ADJx11</sub>	_	10.7	_						
	R <sub>ADJx12</sub>	_	13.7	-						
	R <sub>ADJx13</sub>	_	17.4	_						
	R <sub>ADJx14</sub>	_	23.2	_						
	R <sub>ADJx15</sub>	_	28.0	_						

## **Datasheet**

# infineon

**5 Electrical parameters** 

1) Parameter is not subject to production test - verified by design/characterization

#### **Datasheet**

#### **5 Electrical parameters**



#### 5.4.4 Gate driver

**Note**: High and low level output currents are absolute values without an information of current direction.

Table 14 Gate driver

Parameter	Symbol		Values		Unit	Note or Test	
		Min.	Тур.	Max.		Condition	
High level output voltage	V <sub>ON0</sub>	-	V <sub>VCC2</sub> + 0.87	V <sub>VCC2</sub> + 1.01	V	$I_{\rm ON} = 500  {\rm mA}^{1)}$	
High level output peak current 1ED3431M	I <sub>ON</sub>	2.6	3.8	-	А	$^{2)3)}C_{LOAD} = 33 \text{ nF}$	
High level output on resistance 1ED3431M	R <sub>DSON,H</sub>	0.51	1.12	2.24	Ω	$I_{ON} = 67 \text{ mA}^{3}$	
Low level output peak current 1ED3431M	I <sub>OFF</sub>	2.0	2.5	-	A	$^{2)4)}C_{LOAD} = 33 \text{ nF}$	
Low level ouput on resistance 1ED3431M	$R_{\mathrm{DSON,L}}$	0.31	0.82	1.64	Ω	$I_{OFF} = 67 \text{ mA}^{4}$	
High level output peak current 1ED3461M	I <sub>ON</sub>	5.2	7.5	-	А	$^{2)3)}C_{LOAD} = 68 \text{ nF}$	
High level output on resistance 1ED3461M	R <sub>DSON,H</sub>	0.26	0.56	1.13	Ω	$I_{\rm ON} = 133  {\rm mA}^{3)}$	
Low level output peak current 1ED3461M	I <sub>OFF</sub>	4.0	5.0	-	А	$^{2)4)}C_{LOAD} = 68 \text{ nF}$	
Low level ouput on resistance 1ED3461M	$R_{\mathrm{DSON,L}}$	0.16	0.41	0.83	Ω	I <sub>OFF</sub> = 133 mA <sup>4)</sup>	
High Level output peak current 1ED3491M	I <sub>ON</sub>	7.9	11	-	A	$^{2)3)}C_{LOAD} = 100 \text{ nF}$	
High level output on resistance 1ED3491M	R <sub>DSON,H</sub>	0.17	0.38	0.75	Ω	$I_{ON} = 200 \text{ mA}^{3)}$	
Low Level output peak current 1ED3491M	I <sub>OFF</sub>	6.0	7.5	-	А	$^{2)4)}C_{LOAD} = 100 \text{ nF}$	
Low level ouput on resistance 1ED3491M	$R_{DSON,L}$	0.11	0.28	0.55	Ω	$I_{\rm OFF} = 200  {\rm mA}^{4)}$	
Active Shut Down Voltage <i>OFF</i> 1ED3431M	V <sub>ACTSD</sub> <sup>5)</sup>	-	-	V <sub>VEE2</sub> +2.4	V	$I_{OUT} = 67 \text{ mA}, V_{VCC2}$ open	
Active Shut Down Voltage <i>OFF</i> 1ED3461M	V <sub>ACTSD</sub> <sup>5)</sup>	-	-	V <sub>VEE2</sub> +2.4	V	I <sub>OUT</sub> = 133 mA,V <sub>VCC2</sub> open	
Active Shut Down Voltage <i>OFF</i> 1ED3491M	V <sub>ACTSD</sub> <sup>5)</sup>	-	-	V <sub>VEE2</sub> +2.4	V	I <sub>OUT</sub> = 200 mA,V <sub>VCC2</sub> open	

33

<sup>1)</sup> Integrated diode ON vs. VCC2 clamping test

<sup>2)</sup> Parameter is not subject to production test - verified by design/characterization

<sup>3)</sup>  $IN = High, ON = High; VCC2-ON = 15 V; R_G = 0.1 \Omega; VCC2 = 15 V; VEE2 = -8 V$ 

<sup>4)</sup> IN = Low, OFF = Low; OFF-VEE2 = 15 V;  $R_G = 0.1 \Omega$ ; VCC2 = 15 V; VEE2 = -8 V

<sup>5)</sup> With reference to VEE2

#### **Datasheet**

#### **5 Electrical parameters**



# 5.4.5 Active Miller clamp

#### Table 15 Active Miller clamp

Parameter	Symbol		Values	Unit	Note or Test	
		Min.	Тур.	Max.		Condition
High level clamp	V <sub>CLAMPH0</sub>	_	V <sub>VCC2</sub> +1.5	V <sub>VCC2</sub> +1.63	V	$I_{\text{CLAMP}} = 500 \text{ mA}^{1) 2}$
voltage	V <sub>CLAMPH1</sub>	_	V <sub>VCC2</sub> +0.9	V <sub>VCC2</sub> +1.1	V	$I_{\text{CLAMP}} = 50 \text{ mA}^{1/2}$
Clamp-driver high	$V_{CLAMPDH1}$	V <sub>VEE2</sub> +7.5	V <sub>VEE2</sub> +9.5	V <sub>VEE2</sub> +11.5	V	$I_{\text{CLAMPH}} = 5 \text{ mA}^{3)}$
level output voltage (1ED3461M, 1ED3491M)	V <sub>CLAMPDH2</sub>	V <sub>VEE2</sub> +4.5	V <sub>VEE2</sub> +6.7	_	V	$I_{\text{CLAMPH}} = 50 \text{ mA}^{3)}$
Clamp-driver high level output peak current (1ED3461M, 1ED3491M)	I <sub>CLAMPH</sub>	0.20	0.27	-	A	$^{4)}$ VCC2 = 15 V; VEE2 = 0 V; C <sub>CLAMP</sub> = 100 nF; R <sub>CLAMP</sub> = 1 Ω
Clamp/Clamp-driver output low level current	I <sub>CLAMPL,2</sub>	1.1	1.8	-	A	$^{4)}$ VCC2 = 15 V; VEE2 = 0 V; V <sub>CLAMP</sub> = 2 V; C <sub>CLAMP</sub> = 100 nF; R <sub>CLAMP</sub> = 0.1 Ω
Clamp/Clamp-driver output low level current	I <sub>CLAMPL,5</sub>	2.2	3.5	-	A	$^{4)}$ VCC2 = 15 V; VEE2 = 0 V; V <sub>CLAMP</sub> = 5 V; C <sub>CLAMP</sub> = 100 nF; R <sub>CLAMP</sub> = 0.1 Ω
Clamp/Clamp-driver output low level ON resistance	R <sub>DSON,CLP</sub>	0.50	0.85	1.35	Ω	I <sub>CLAMPL</sub> = 200 mA
Clamp threshold voltage	V <sub>ON_CLAMP</sub>	1.5	2.0	2.5	V	Related to VEE2
Clamp filter time	t <sub>CLAMPfilter</sub>	195	235	275	ns	
CLAMP reaction time in CLAMP mode	t <sub>CLAMP_ON</sub>	16 + t <sub>CLAMPfilter</sub>	23 + t <sub>CLAMPfilter</sub>	35 + t <sub>CLAMPfilter</sub>	ns	$^{4)} C_{LOAD} = 100 \text{ pF}$
CLAMP reaction time in CLAMP driver mode	t <sub>CLAMPD_ON</sub>	24 + t <sub>CLAMPfilter</sub>	35 + t <sub>CLAMPfilter</sub>	53 + t <sub>CLAMPfilter</sub>	ns	$^{4) 6)} C_{LOAD} = 100 \text{ pF}$
Switch-off time-out time	$t_{\text{CTT}}$	-	2.4	-	μs	4)
Switch-off time-out soft-off offset time	t <sub>CTSOOS</sub>	-	2.4	-	μs	<sup>4)</sup> additional time-out delay during soft-off

- 1) Integrated diode CLAMP vs. VCC2 clamping test
- 2) only valid for direct clamping: *IN* = High, *OUT* = High
- 3) only valid for clamp pre-driver output: *IN* = Low, *OUT* = Low
- 4) Parameter is not subject to production test verified by design/characterization
- 5) CLAMP mode reaction time specified with 3.3 k $\Omega$  pull-up from *CLAMP* to 3.3 V, from CLAMP threshold until reaching 0.8 V (falling) at *CLAMP* pin
- 6) CLAMP driver mode reaction time specified from CLAMP threshold until reaching 0.8 V (rising) at CLAMP(DRV) pin

#### **Datasheet**

# 5 Electrical parameters



# **5.4.6 Dynamic characteristics**

Dynamic characteristics are measured with  $V_{VCC1} = 5 \text{ V}$ ,  $V_{VCC2} = 15 \text{ V}$  and  $V_{VEE2} = -8 \text{ V}$  unless specified otherwise.

Table 16Dynamic characteristics

Parameter	Symbol		Values		Unit	Note or Test	
		Min.	Тур.	Max.		Condition	
Input pulse suppression time IN	t <sub>INMIN</sub>	98	103	108	ns	-	
Input pulse suppression time RDYC/FLT_N for enable / fault off	$t_{\mathrm{RDYCMIN}}, \ t_{\mathrm{FLT\_NMIN}}$	85	100	115	ns	-	
Input pulse width RDYC for FLT_N reset (Fault clear time)	t <sub>CLRMIN</sub>	-	1.0	1.2	μs		
Input IN to output propagation delay ON	$t_{PDON}$	226	244	270	ns	$C_{\text{LOAD}} = 100 \text{ pF, } V_{\text{IN}} = 70\%, V_{\text{OUT}} = 20\%$	
Input IN to output propagation delay OFF	$t_{PDOFF}$	218	236	262	ns	$C_{LOAD} = 100 \text{ pF, } V_{IN} = 30\%, V_{OUT} = 80\%$	
Input to output propagation delay distortion ( $t_{PDOFF}$ - $t_{PDON}$ )	$t_{PDISTO}$	-23	-8	7	ns	C <sub>LOAD</sub> = 100 pF	
Input <i>IN</i> to output propagation delay distortion between any devices ( $t_{PDON}$ - $t_{PDON}$ ) or ( $t_{PDOFF}$ - $t_{PDOFF}$ )	$t_{PDD}$	-	-	30	ns	1) same conditions $(V_{\text{IN}}, V_{\text{VCC1}}, V_{\text{VCC2}} \text{ and } V_{\text{VEE2}}, C_{\text{LOAD}}, T_{\text{A}})$	
State synchronization time between input and output	t <sub>SSIO</sub>	-	-	13	μs	1)	
Input RDYC to output on propagation delay	$t_{ extsf{PDRDYC}}$	447	523	600	ns	$C_{LOAD}$ = 100 pF; /N high; $V_{RDYC}$ = 70%, $V_{OUT}$ =20%	
Input RDYC or FLT_N to Soft-off output propagation delay	t <sub>PDRDYCS</sub> , t <sub>PDFLT_NS</sub>	323	361	407	ns	$C_{\text{LOAD}} = 100 \text{ pF}, V_{\text{Signal}}$ = 30%, $V_{\text{OUT}} = 80\%$ , Soft-off function $I_{\text{CSOFF,15}}$	
Rise time 1ED3431M	$t_{RISE}$	_	15	30	ns	$C_{LOAD} = 1 \text{ nF}, V_{OUT}$ : 20% to 80%	
Fall time 1ED3431M	t <sub>FALL</sub>	-	15	30	ns	C <sub>LOAD</sub> = 1 nF, V <sub>OUT</sub> : 80% to 20%	
Rise time 1ED3461M	t <sub>RISE</sub>	-	15	30	ns	C <sub>LOAD</sub> = 2.2 nF, V <sub>OUT</sub> : 20% to 80%	
Fall Time 1ED3461M	t <sub>FALL</sub>	-	15	30	ns	$C_{LOAD} = 2.2 \text{ nF}, V_{OUT}$ : 80% to 20%	

(table continues...)

v1.20

#### **Datasheet**

#### **5 Electrical parameters**



Table 16 (continued) Dynamic characteristics

Parameter	Symbol	Symbol Values			Unit	Note or Test	
		Min.	Тур.	Max.		Condition	
Rise Time 1ED3491M	$t_{RISE}$	-	15	30	ns	C <sub>LOAD</sub> = 3.3 nF, V <sub>OUT</sub> : 20% to 80%	
Fall Time 1ED3491M	$t_{FALL}$	_	15	30	ns	C <sub>LOAD</sub> = 3.3 nF, V <sub>OUT</sub> : 80% to 20%	

<sup>1)</sup> Parameter is not subject to production test - verified by design/characterization

# 5.4.7 Desaturation protection

All parameters valid for VCC1 = 5 V, VCC2 = 15 V, and VEE2 = 0 V unless specified otherwise.

Table 17Desaturation protection

Parameter	Symbol		Values		Unit	Note or Test Condition	
		Min.	Тур.	Max.			
DESAT charge current	I <sub>DESATC</sub>	470	500	525	μΑ	V <sub>DESAT</sub> = 0 V	
DESAT voltage divider resistance	$R_{DVD}$	259	312.5	366	kΩ	between DESAT and GND2 pins	
DESAT clamp and discharge ON resistance	R <sub>DSON,D</sub>	-	7.7	25.0	Ω	I <sub>DESATD</sub> = 200 mA	
DESAT threshold level	$V_{DESAT}$	8.88	9.18	9.48	V	-	
DESAT leading edge	t <sub>DESATleb,d</sub>	356	400	444	ns	ADJB depending, V <sub>ON</sub>	
blanking time	t <sub>DESATleb,s</sub>	597	650	703	ns	20% rising to $V_{\text{DESAT}}$ = 1 V, $C_{\text{LOAD}}$ = 100 pF,	
	$t_{DESATleb,l}$	1077	1150	1223	ns	$C_{\text{DESAT}} = 2 \text{ pF},$	
DESAT filter time (default)	t <sub>DESATfilter,def</sub>	190	225	263	ns	ADJB = VCC1	
DESAT filter time (ADJB	t <sub>DESATfilter,A</sub>	1476	1575	1684	ns	ADJB depending	
adjustable)	$t_{DESATfilter,B}$	1667	1775	1895	ns		
	$t_{DESATfilter,C}$	1857	1975	2105	ns		
	t <sub>DESATfilter,D</sub>	2238	2375	2526	ns		
	t <sub>DESATfilter,E</sub>	2619	2775	2947	ns		
	t <sub>DESATfilter,F</sub>	3000	3175	3368	ns		
	t <sub>DESATfilter,G</sub>	3381	3575	3789	ns		
	t <sub>DESATfilter,H</sub>	3762	3975	4211	ns		
DESAT sense to FLT_N low delay	t <sub>DESATFLT</sub>	623	743	883	ns	$V_{\rm FLT\_N} = 30\%, I_{\rm FLT\_N}$ = 5 mA, $t_{\rm DESATfilter,def},$ $C_{\rm FLT\_N} = 100  \rm pF$	

(table continues...)

## **Datasheet**



## **5 Electrical parameters**

## Table 17 (continued) Desaturation protection

Parameter	Symbol		Values			Note or Test
		Min.	Тур.	Max.		Condition
DESAT sense to <i>OFF</i> low delay, Soft-off	t <sub>DESATOUTS</sub>	287 + t <sub>DESATfilter</sub>	333 + t <sub>DESATfilter</sub>	382 + t <sub>DESATfilter</sub>	ns	$V_{\text{OUT}} = 80\%, C_{\text{LOAD}} = 100 \text{ pF}, I_{\text{CSOFF,15}}$

#### **Datasheet**



**5 Electrical parameters** 

## **5.4.8 Soft-off current source**

Soft-off current source values specified at *OFF* pin at  $V_{OFF}$  = 3 V with unipolar supply of  $V_{VCC2}$  = 15 V.

Table 18 Current source turn-off

Parameter	Symbol		Values		Unit	Note or Test
		Min.	Тур.	Max.		Condition
Soft-off current source current 1ED3431M	I <sub>CSOFF,0</sub>	10	15	19	mA	depends on resistor
	I <sub>CSOFF,1</sub>	24	29	36	mA	value at <i>ADJA</i>
	I <sub>CSOFF,2</sub>	35	44	52	mA	
	I <sub>CSOFF,3</sub>	47	58	70	mA	
	I <sub>CSOFF,4</sub>	58	73	87	mA	
	I <sub>CSOFF5</sub>	70	87	105	mA	
	I <sub>CSOFF,6</sub>	82	102	122	mA	
	I <sub>CSOFF,7</sub>	93	116	140	mA	
	I <sub>CSOFF,8</sub>	105	131	157	mA	
	I <sub>CSOFF,9</sub>	116	146	175	mA	
	I <sub>CSOFF,10</sub>	128	160	192	mA	
	I <sub>CSOFF,11</sub>	140	175	210	mA	
	I <sub>CSOFF,12</sub>	151	189	227	mA	
	I <sub>CSOFF,13</sub>	163	204	245	mA	
	I <sub>CSOFF,14</sub>	175	218	262	mA	
	I <sub>CSOFF,15</sub>	186	233	280	mA	
Soft-off current source	I <sub>CSOFF,0</sub>	22	29	36	mA	depends on resisto
current 1ED3461M	I <sub>CSOFF,1</sub>	45	58	72	mA	value at <i>ADJA</i>
	I <sub>CSOFF,2</sub>	70	87	105	mA	
	I <sub>CSOFF,3</sub>	93	116	140	mA	
	I <sub>CSOFF,4</sub>	116	146	175	mA	
	I <sub>CSOFF,5</sub>	140	175	210	mA	
	I <sub>CSOFF,6</sub>	163	204	245	mA	
	I <sub>CSOFF,7</sub>	186	233	280	mA	
	I <sub>CSOFF,8</sub>	210	262	314	mA	
	I <sub>CSOFF,9</sub>	233	291	349	mA	
	I <sub>CSOFF,10</sub>	256	320	384	mA	
	I <sub>CSOFF,11</sub>	280	349	419	mA	
	I <sub>CSOFF,12</sub>	303	379	454	mA	
	I <sub>CSOFF,13</sub>	326	408	489	mA	

(table continues...)

#### **Datasheet**



#### **5 Electrical parameters**

Table 18 (continued) Current source turn-off

Parameter	Symbol	Values			Unit	Note or Test
		Min.	Тур.	Max.		Condition
	I <sub>CSOFF,14</sub>	349	437	524	mA	
	I <sub>CSOFF,15</sub>	373	466	559	mA	
Soft-off current source	I <sub>CSOFF,0</sub>	34	44	54	mA	depends on resistor
current 1ED3491M	I <sub>CSOFF,1</sub>	70	87	105	mA	value at <i>ADJA</i>
	I <sub>CSOFF,2</sub>	105	131	157	mA	
	I <sub>CSOFF,3</sub>	140	175	210	mA	
	I <sub>CSOFF,4</sub>	175	218	262	mA	
	I <sub>CSOFF,5</sub>	210	262	314	mA	
	I <sub>CSOFF,6</sub>	245	306	367	mA	
	I <sub>CSOFF,7</sub>	280	349	419	mA	
	I <sub>CSOFF,8</sub>	314	393	472	mA	
	I <sub>CSOFF,9</sub>	349	437	524	mA	
	I <sub>CSOFF,10</sub>	384	480	577	mA	
	I <sub>CSOFF,11</sub>	419	524	629	mA	
	I <sub>CSOFF,12</sub>	454	568	681	mA	
	I <sub>CSOFF,13</sub>	489	612	734	mA	
	I <sub>CSOFF,14</sub>	524	655	786	mA	
	I <sub>CSOFF,15</sub>	559	699	839	mA	

# 5.4.9 Over-temperature protection

Table 19 Over-temperature protection

Parameter <sup>1)</sup>	Symbol	Values			Unit	Note or Test
		Min.	Тур.	Max.		Condition
Over-temperature protection level	T <sub>OTPOFF</sub>	150	160	170	°C	

<sup>1)</sup> Parameter is not subject to production test - verified by design/characterization

# EiceDRIVER™ 1ED34x1Mc12M Enhanced Datasheet



6 Insulation characteristics (IEC 60747-17, UL 1577) for 1ED34x1MC12M

# 6 Insulation characteristics (IEC 60747-17, UL 1577) for 1ED34x1MC12M

This coupler is suitable for rated insulation only within the given safety ratings. Compliance with the safety ratings shall be ensured by means of suitable protective circuits.

Table 20	Insulation specification for 1ED34x1MC12M
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Description	Symbol	Characteristic	Unit
Safety limiting values			•
Maximum ambient safety temperature	$T_{S}$	150	°C
Maximum input-side power dissipation at $T_A = 25^{\circ}C^{1}$	$P_{SI}$	100	mW
Maximum output-side power dissipation at $T_A = 25^{\circ}C^{2}$	$P_{SO}$	1000	mW
General			
External clearance	CLR	> 8	mm
External creepage	CPG	> 8	mm
Comparative tracking index	CTI	> 400	_
Isolation capacitance	C <sub>IO</sub>	1.7	pF
Overvoltage category according to IEC 60664-1, Table F.1			_
for rated mains voltage ≤ 150 V (rms)		I-IV	
for rated mains voltage ≤ 300 V (rms)		I-IV	
for rated mains voltage ≤ 600 V (rms)		I-IV	
for rated mains voltage ≤1000 V (rms)		1-111	
Reinforced insulation according to IEC 60747-17 (Certificate no. 400557	743)		•
Climatic classification		40/125/21	_
Pollution degree (IEC 60664-1)		2	_
Apparent charge, method a	$q_{pd}$	< 5	pC
$V_{\rm pd(ini),a} = V_{\rm IOTM}, V_{\rm pd(m)} = 1.6 \times V_{\rm IORM}, t_{\rm ini} = 1  {\rm min}, t_{\rm m} = 10  {\rm s}$			
Apparent charge, method b	$q_{pd}$	< 5	pC
$V_{pd(ini),b} = V_{IOTM} \times 1.2$ , $V_{pd(m)} = 1.875 \times V_{IORM}$ , $t_{ini} = 1$ s, $t_m = 1$ s			
Isolation resistance at $T_{A,max}$ ; $V_{IO}$ = 500 $V_{DC}$ , $T_A$ = 125°C	R <sub>IO</sub>	> 10 <sup>11</sup>	Ω
Isolation resistance at $T_S$ ; $V_{IO}$ = 500 $V_{DC}$ , $T_S$ = 150°C	R <sub>IO_S</sub>	> 10 <sup>9</sup>	Ω
Maximum rated transient isolation voltage	$V_{IOTM}$	8000	V (peak)
Maximum repetitive isolation voltage	$V_{IORM}$	1767	V (peak)
Maximum working isolation voltage	$V_{\text{IOWM}}$	1250	V (rms)
		1767	V (DC)
Impulse voltage	V <sub>IMP</sub>	8000	V (peak)
Maximum surge isolation voltage for reinforced isolation; $V_{\text{TEST}} \ge V_{\text{IMP}} \times 1.3$	$V_{IOSM}$	11000	V (peak)
Recognized under UL 1577 (File E311313)			
Insulation withstand voltage (60 s)	$V_{\rm ISO}$	5700	V (rms)
Insulation test voltage (1 s)	V <sub>ISO,TEST</sub>	6840	V (rms)
IC input-side power dissipation is derated linearly at 2 mW/°C above 125°C	, ,	1	1

<sup>2)</sup> IC output-side power dissipation id derated linearly at 8 mW/°C above 65°C

# EiceDRIVER™ 1ED34x1Mc12M Enhanced Datasheet



7 Insulation characteristics (UL 1577) for 1ED34x1MU12M

# 7 Insulation characteristics (UL 1577) for 1ED34x1MU12M

This coupler is suitable for rated insulation only within the given safety ratings. Compliance with the safety ratings shall be ensured by means of suitable protective circuits.

Table 21 Insulation specification for 1ED34x1MU12M

Description	Symbol	Characteristic	Unit
Safety limiting values		,	
Maximum ambient safety temperature	$T_{S}$	150	°C
Maximum input-side power dissipation at $T_A = 25^{\circ}C^{1}$	$P_{SI}$	100	mW
Maximum output-side power dissipation at $T_A = 25^{\circ}C^{2/}$	$P_{SO}$	1000	mW
Package specific insulation characteristics			
External clearance	CLR	> 8	mm
External creepage	CPG	> 8	mm
Comparative tracking index	CTI	> 400	-
Isolation capacitance	C <sub>IO</sub>	1.7	pF
Recognized under UL 1577 (File E311313)	·		
Insulation withstand voltage (60 s)	$V_{\rm ISO}$	5700	V (rm
Insulation test voltage (1 s)	$V_{\rm ISO,TEST}$	6840	V (rms

<sup>1)</sup> IC input-side power dissipation is derated linearly at 2 mW/°C above 125°C

<sup>2)</sup> IC output-side power dissipation id derated linearly at 8 mW/°C above 65°C

#### **Datasheet**





#### **Package information** 8

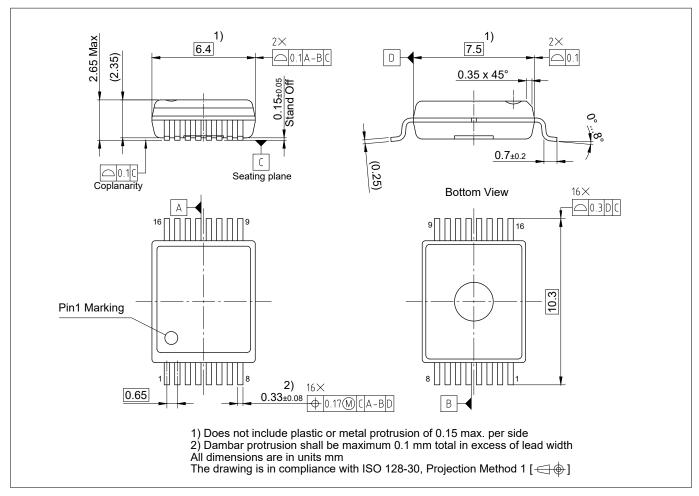


Figure 24 PG-DSO-16-28/33 - 300 mil 16-pin fine pitch plastic green dual small outline package

# **(infineon**

#### 9 Application notes

# 9 Application notes

## 9.1 Reference layout for thermal data

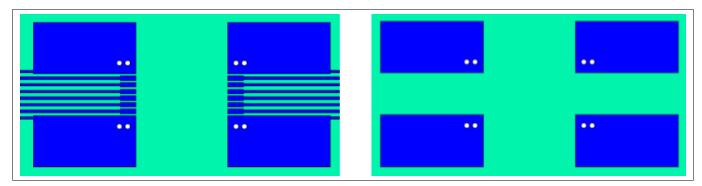


Figure 25 Reference layout for thermal data (Two layer PCB; copper thickness 35 µm; left: top layer; right: bottom layer)

The PCB layout represents the reference layout used for the thermal characterization. Pins 1 and 8 (*GND1*) and pins 9 and 16 (*VEE2*) require ground plane connections for achieving maximum power dissipation. The 1ED34x1Mc12M family (X3 Analog) is conceived to dissipate most of the heat generated through these pins.

#### 9.2 Printed circuit board guidelines

Following factors should be taken into account for an optimum PCB layout.

- Sufficient spacing should be kept between high voltage isolated side and low voltage side circuits.
- The same minimum distance between two adjacent high-side isolated parts of the PCB should be maintained to increase the effective isolation and reduce parasitic coupling.
- In order to ensure low supply ripple and clean switching signals, bypass capacitor trace lengths should be kept as short as possible.

# **Revision history**

## **Revision history**

Reference	Description
1.10 (2021-10-08)	<ul> <li>Certification information update (VDE certification)</li> <li>Fix unit and conditions in certification table according to standards</li> <li>Related product table update</li> </ul>
1.11 (2021-10-27)	• Removed line in dynamic characteristics which does not apply to this product: $t_{\rm PDRDYCH}$ , $t_{\rm PDFLT\_NH}$
1.20 (2025-08-07)	<ul> <li>Certification information transition from VDE to IEC</li> <li>Harmonized certification template</li> </ul>

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